## NUS3065MU

## Low Profile Overvoltage Protection IC with Integrated MOSFET

This device represents a new level of safety and integration by combining the NCP345 overvoltage protection circuit (OVP) with a 30 V P -channel power MOSFET. It is specifically designed to protect sensitive electronic circuitry from overvoltage transients and power supply faults. During such hazardous events, the IC quickly disconnects the input supply from the load, thus protecting the load before any damage can occur.

The OVP IC is optimized for applications that use an external AC-DC adapter or a car accessory charger to power a portable product or recharge its internal batteries. It has a nominal overvoltage threshold of 6.85 V which makes them ideal for single cell $\mathrm{Li}-\mathrm{Ion}$ as well as $3 / 4$ cell NiCD/NiMH applications.

## Features

- OvervoltageTurn-Off Time of Less Than $1.0 \mu \mathrm{~s}$
- Accurate Voltage Threshold of 6.85 V , Nominal
- Undervoltage Lockout Protection; 2.8 V, Nominal
- High Accuracy Undervoltage Threshold of 2.0\%
- -30 V Integrated P-Channel Power MOSFET
- Low $\mathrm{R}_{\mathrm{DS}(\text { on })}=66 \mathrm{~m} \Omega$ @ -4.5 V
- Low Profile 0.55 mm height, 2.5 X 3.0 mm LLGA Package Suitable for Portable Applications
- Maximum Solder Reflow Temperature @ $260^{\circ} \mathrm{C}$
- This device is manufactured with a $\mathrm{Pb}-$ Free external lead finish only.
- This is a $\mathrm{Pb}-$ Free Device


## Benefits

- Provide Battery Protection
- Integrated Solution Offers Cost and Space Savings
- Integrated Solution Improves System Reliability


## Applications

- Portable Computers and PDAs
- Cell Phones and Handheld Products
- Digital Cameras

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MARKING
DIAGRAM

## PIN CONNECTIONS


(Bottom View)

## ORDERING INFORMATION

| Device | Package | Shipping $^{\dagger}$ |
| :---: | :---: | :---: |
| NUS3065MUTAG | TLLGA8 <br> (Pb-Free) | $3000 /$ <br> Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.


Figure 1. Simplified Schematic

## PIN FUNCTION DESCRIPTIONS

| Pin \# | Symbol | Pin Description |
| :---: | :---: | :---: |
| 1 | IN | This pin senses an external voltage point. If the voltage on this input rises above the overvoltage threshold $\left(\mathrm{V}_{\mathrm{TH}}\right)$, the OUT pin will be driven to within 1.0 V of $\mathrm{V}_{\mathrm{CC}}$, thus disconnecting the P -Channel Power MOSFET. The nominal threshold level is 6.85 V and this threshold level can be increased with the addition of an external resistor between IN and $\mathrm{V}_{\mathrm{CC}}$. |
| 2 | GND | Circuit Ground |
| 3 | CNTRL | This logic signal is used to control the state of OUT and turn-on/off the P-Channel Power MOSFET. A logic High results in the OUT signal being driven to within 1.0 V of $\mathrm{V}_{\mathrm{CC}}$ which disconnects the FET. If this pin is not used, the input should be connected to ground. |
| 4 | DRAIN | Drain pin of the P-Channel Power MOSFET |
| 5 | SRC | Source pin of the P-Channel Power MOSFET |
| 6 | GATE | Gate pin of the P-Channel Power MOSFET |
| 7 | OUT | This signal drives the gate of a P-Channel Power MOSFET. It is controlled by the voltage level on IN or the logic state of the CNTRL input. When an overvoltage event is detected, the OUT pin is driven to within 1.0 V of $\mathrm{V}_{\text {CC }}$ in less than 1.0 _sec provided that gate and stray capacitance is less than 12 nF . |
| 8 | $\mathrm{V}_{\mathrm{CC}}$ | Positive Voltage supply. If $\mathrm{V}_{\mathrm{CC}}$ falls below 2.8 V (nom), the OUT pin will be driven to within 1.0 V of $\mathrm{V}_{\mathrm{CC}}$, thus disconnecting the P -channel FET. |

OVERVOLTAGE PROTECTION CIRCUIT TRUTH TABLE

| IN | CNTRL | OUT |
| :---: | :---: | :---: |
| $<\mathrm{V}_{\text {th }}$ | L | GND |
| $<\mathrm{V}_{\text {th }}$ | H | $\mathrm{V}_{\mathrm{CC}}$ |
| $>\mathrm{V}_{\text {th }}$ | L | $\mathrm{V}_{\mathrm{CC}}$ |
| $>\mathrm{V}_{\text {th }}$ | H | $\mathrm{V}_{\mathrm{CC}}$ |

MAXIMUM RATINGS ( $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise stated)

| Rating | Pin | Symbol | Min | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| OUT Voltage to GND | 7 | $\mathrm{V}_{\mathrm{O}}$ | -0.3 | 30 | V |
| Input and CNTRL Pin Voltage to GND | $\begin{aligned} & 1 \\ & 3 \end{aligned}$ | $V_{\text {input }}$ <br> $V_{\text {CNTRL }}$ | $\begin{aligned} & \hline-0.3 \\ & -0.3 \end{aligned}$ | $\begin{aligned} & 30 \\ & 13 \end{aligned}$ | V |
| Vcc Maximum Range | 8 | $\mathrm{V}_{\mathrm{CC} \text { (max) }}$ | -0.3 | 30 | V |
| Maximum Power Dissipation (Note 1) | - | $\mathrm{P}_{\mathrm{D}}$ | - | 1.0 | W |
| Thermal Resistance Junction-to-Air (Note 1) $\begin{array}{r}\text { OVP IC } \\ \\ \text { P-Channel FET }\end{array}$ | - | $\mathrm{R}_{\text {өJA }}$ | - | $\begin{aligned} & 342 \\ & 124 \end{aligned}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Junction Temperature | - | $\mathrm{T}_{J}$ | - | 150 | ${ }^{\circ} \mathrm{C}$ |
| Operating Ambient Temperature | - | $\mathrm{T}_{\mathrm{A}}$ | -40 | 85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{V}_{\text {CNTRL }}$ Operating Voltage | 3 | - | 0 | 5.0 | V |
| Storage Temperature Range | - | $\mathrm{T}_{\text {stg }}$ | -65 | 150 | ${ }^{\circ} \mathrm{C}$ |
| ESD Performance (HBM) (Note 2) | 1, 2, 3, 7, 8 | - | 2.5 | - | kV |
| Drain-to-Source Voltage |  | $\mathrm{V}_{\text {DSS }}$ |  | -30 | V |
| Gate-to-Source Voltage |  | $\mathrm{V}_{\mathrm{GS}}$ | -20 | 20 | V |
| Continuous Drain Current, Steady State, $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ (Note 1) |  | ID |  | -1.0 | A |
| Drain Current, Peak (Note 1) $\mathrm{P}_{\mathrm{W}}=500 \mu \mathrm{~s}, \mathrm{~T}_{\mathrm{A}}=80^{\circ} \mathrm{C}$ |  | IDPK |  | -4.0 | A |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 inch sq pad size ( Cu area $=1.127$ in sq [1 oz] including traces).
2. Human body model (HBM): MIL STD 883C Method 3015-7, ( $R=1500 \Omega, C=100 \mathrm{pF}, \mathrm{F}=3$ pulses delay 1 s$)$.

ELECTRICAL CHARACTERISTICS $\left(T_{A}=25^{\circ} \mathrm{C}, \mathrm{Vcc}=6.0 \mathrm{~V}\right.$, unless otherwise specified)

| Characteristic | Symbol | Pin | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {CC }}$ Operating Voltage Range | $\mathrm{V}_{\text {CC(opt) }}$ | 8 | 3.0 | 4.8 | 25 | V |
| Supply Current ( $\mathrm{I}_{\text {cc }}+$ IInput; $\mathrm{V}_{\text {CC }}=6.0 \mathrm{~V}$ Steady State) | - | 1,8 | - | 0.75 | 1.0 | mA |
| Input Threshold ( $\mathrm{V}_{\text {Input }}$ connected to $\mathrm{V}_{\mathrm{Cc}}$; $\mathrm{V}_{\text {Input }}$ increasing) | $\mathrm{V}_{\text {Th }}$ | 1 | 6.65 | 6.85 | 7.08 | V |
| Input Hysteresis ( $\mathrm{V}_{\text {Input }}$ connected to $\mathrm{V}_{\mathrm{CC}}$; $\mathrm{V}_{\text {Input }}$ decreasing) | $\mathrm{V}_{\text {Hyst }}$ | 1 | 50 | 100 | 200 | mV |
| Input Impedance ( Input = $\mathrm{V}_{\text {Th }}$ ) | $\mathrm{R}_{\text {in }}$ | 1 | 70 | 150 | - | $\mathrm{k} \Omega$ |
| CNTRL Voltage High | $V_{\text {ih }}$ | 3 | 1.5 | - | - | V |
| CNTRL Voltage Low | $\mathrm{V}_{\mathrm{il}}$ | 3 | - | - | 0.5 | V |
| CNTRL Current High ( $\mathrm{V}_{\text {ih }}=5.0 \mathrm{~V}$ ) | $\mathrm{l}_{\text {ih }}$ | 3 | - | 95 | 200 | $\mu \mathrm{A}$ |
| CNTRL Current Low ( $\mathrm{V}_{\mathrm{il}}=0.5 \mathrm{~V}$ ) | $\mathrm{l}_{\mathrm{il}}$ | 3 | - | 10 | 20 | $\mu \mathrm{A}$ |
| Undervoltage Lockout ( $\mathrm{V}_{\mathrm{CC}}$ decreasing) | $\mathrm{V}_{\text {Lock }}$ | 3 | 2.5 | 2.8 | 3.0 | V |
| Output Sink Current ( $\left.\mathrm{V}_{\text {CC }}<\mathrm{V}_{\text {Th }}, \mathrm{V}_{\text {OUT }}=1.0 \mathrm{~V}\right)$ | $\mathrm{I}_{\text {Sink }}$ | 7 | 10 | 33 | 50 | $\mu \mathrm{A}$ |
| $\begin{aligned} & \text { Output Voltage High }\left(\mathrm{V}_{\mathrm{CC}}=\mathrm{V}_{\text {in }}=8.0 \mathrm{~V} \text {; } I_{\text {Source }}=10 \mathrm{~mA}\right) \\ & \text { Output Voltage High }\left(\mathrm{V}_{\mathrm{CC}}=\mathrm{V}_{\text {in }}=8.0 \mathrm{~V} \text {; } I_{\text {Source }}=0.25 \mathrm{~mA}\right) \\ & \text { Output Voltage High }\left(\mathrm{V}_{\mathrm{CC}}=\mathrm{V}_{\text {in }}=8.0 \mathrm{~V} \text {; } I_{\text {Source }}=0 \mathrm{~mA}\right) \end{aligned}$ | $\mathrm{V}_{\text {oh }}$ | 7 | $\begin{gathered} \mathrm{V}_{\mathrm{CC}}-1.0 \\ \mathrm{~V}_{\mathrm{CC}}-0.25 \\ \mathrm{~V}_{\mathrm{CC}}-0.1 \end{gathered}$ | - | - | V |
| Output Voltage Low (Input $<6.5 \mathrm{~V}$; $\mathrm{I}_{\text {Sink }}=0 \mathrm{~mA}$; $\mathrm{V}_{\mathrm{CC}}=6.0 \mathrm{~V}, \mathrm{CNTRL}=0 \mathrm{~V}$ ) | Vol | 7 | - | - | 0.1 | V |
| Turn ON Delay - Input (Note 3) <br> ( $\mathrm{V}_{\text {Input }}$ connected to $\mathrm{V}_{\mathrm{CC}} ; \mathrm{V}_{\text {Input }}$ step down signal from 8.0 to <br> 6.0 V ; measured to $50 \%$ point of OUT)* | Ton In | 7 | - | - | 10 | us |
| Turn OFF Delay - Input ( $\mathrm{V}_{\text {Input }}$ connected to $\mathrm{V}_{\mathrm{Cc}} ; \mathrm{V}_{\text {Input }}$ step up signal from 6.0 to 8.0 V ; $\mathrm{C}_{\mathrm{L}}=12 \mathrm{nF}$ Output $>\mathrm{V}_{\mathrm{CC}}-1.0 \mathrm{~V}$ ) | TofF IN | 7 | - | 0.5 | 1.0 | us |
| Turn ON Delay - CNTRL (CNTRL step down signal from 2.0 to 0.5 V ; measured to $50 \%$ point of OUT) (Note 3) | TON CT | 7 | - | - | 10 | $\mu \mathrm{S}$ |
| Turn OFF Delay - CNTRL (CNTRL step up signal from 0.5 to 2.0 V; $\mathrm{C}_{\mathrm{L}}=12 \mathrm{nF}$ Output $>\mathrm{V}_{\mathrm{CC}}-1.0 \mathrm{~V}$ ) | TofF CT | 7 | - | 1.0 | 2.0 | $\mu \mathrm{S}$ |

3. Guaranteed by design.

P-CHANNEL MOSFET ( $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise specified)

| Parameter | Symbol | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Drain to Source On Resistance $\begin{aligned} & \left(\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=600 \mathrm{~mA}\right) \\ & \left(\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1.0 \mathrm{~A}\right) \end{aligned}$ | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ |  | $\begin{aligned} & 66 \\ & 66 \end{aligned}$ | $\begin{aligned} & 100 \\ & 100 \end{aligned}$ | $\mathrm{m} \Omega$ |
| Zero Gate Voltage Drain Current $\left(\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=-24 \mathrm{~V}\right)$ | IDSS |  |  | -1.0 | $\mu \mathrm{A}$ |
| Turn On Delay (Note 4) $\left(\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-1.0 \mathrm{~A}, \mathrm{R}_{\mathrm{G}}=6.0 \Omega, \mathrm{~V}_{\mathrm{DS}}=15 \mathrm{~V}\right)$ | ton |  | 11 |  | ns |
| Turn Off Delay (Note 4) $\left(\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-1.0 \mathrm{~A}, \mathrm{R}_{\mathrm{G}}=6.0 \Omega, \mathrm{~V}_{\mathrm{DS}}=15 \mathrm{~V}\right)$ | $\mathrm{t}_{\text {off }}$ |  | 28 |  | ns |
| Input Capacitance (Note 3) $\left(\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1.0 \mathrm{MHz}, \mathrm{~V}_{\mathrm{DS}}=-15 \mathrm{~V}\right)$ | $\mathrm{C}_{\text {in }}$ |  | 750 |  | pF |
| Gate to Source Leakage Current $\left(\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}\right)$ | $I_{\text {GSS }}$ |  | $\pm 10$ |  | nA |
| Drain to Source Breakdown Voltage $\left(\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}\right)$ | $\mathrm{V}_{(\mathrm{BR}) \mathrm{DSS}}$ | 30 |  |  | V |
| Gate Threshold Voltage $\left(\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}\right)$ | $\mathrm{V}_{\text {(GS)th }}$ | -3.0 |  | -1.0 | V |

4. Switching characteristics are independent of operating junction temperature.

TYPICAL PERFORMANCE CURVES
( $T_{A}=25^{\circ} \mathrm{C}$, unless otherwise specified)
OVERVOLTAGE PROTECTION IC


Figure 2. Typical $\mathrm{V}_{\text {th }}$ Threshold Variation vs. Temperature


Figure 3. Typical Supply Current vs. Temperature

$$
I_{c c}+I_{i n}, V_{c c}=6 V
$$



Figure 4. Typical Maximum Drain Peak Current vs Pulse Width (Non-repetitive Single Pulse, $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ )

## NUS3065MU

TYPICAL PERFORMANCE CURVES
( $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise specified)
30 V, P-CHANNEL MOSFET


Figure 5. On-Region Characteristics


Figure 7. Drain-to-Source Leakage Current vs. Voltage


Figure 6. On-Resistance vs. Gate-to-Source Voltage


Figure 8. Diode Forward Voltage vs. Current

TYPICAL APPLICATION CIRCUITS \& OPERATION WAVEFORMS
( $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise specified)


Figure 9. Test Circuit for $\mathrm{T}_{\mathrm{ON} \text { IN }}$ and $\mathrm{T}_{\text {OFF IN }}$


Figure 10. ToN in Waveforms


Figure 11. Toff in Waveforms


Figure 12. Test Circuit for $\mathrm{T}_{\mathrm{ON}}$ CT and $\mathrm{T}_{\text {OFF }}$ CT

NUS3065MU


Figure 13. $\mathrm{T}_{\mathrm{ON}} \mathrm{CT}$ Waveforms


Figure 14. Toff ct Waveforms

## PACKAGE DIMENSIONS

LLGA8 3x2.5, 0.65P
CASE 517AH
ISSUE A


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994
. CONTROLLING DIMENSION: MILLIMETERS.
2. DIMENSION b APPLIES TO PLATED TERMINAL

AND IS MEASURED BETWEEN 0.15 AND
AND IS MEASURED BETWEEN
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

|  | MILLIMETERS |  |  |
| :---: | :---: | :---: | :---: |
| DIM | MIN | MAX |  |
| A | 0.50 | 0.60 |  |
| A1 | 0.00 | 0.05 |  |
| b | 0.35 | 0.45 |  |
| b2 | 0.45 | 0.55 |  |
| D | 3.00 BSC |  |  |
| D2 | 1.25 |  |  |
| E | 1.35 |  |  |
| E2 | 2.50 |  |  |
|  | BSC | 1.65 |  |
| e | 0.65 BSC |  |  |
| G | 0.05 |  |  |
| REF |  |  |  |
| K | 0.15 |  |  |
| REF |  |  |  |
| L | 0.35 | 0.45 |  |

## SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

[^0]
## PUBLICATION ORDERING INFORMATION

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